Degradation of aqueous carbon tetrachloride by nanoscale zerovalent copper on a cation resin

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Abstract

Nanoscale zerovalent copper supported on a cation resin was successfully synthesized to enhance the removal of carbon tetrachloride (CCl₄) from contaminated water. The use of the cation resin as a support prevents the reduction of surface area due to agglomeration of nanoscale zerovalent copper particles. Moreover, the cation resin recycles the copper ions resulting from the reaction between CCl₄ and Cu⁰ by simultaneous ion exchange. The decline in the amount of CCl₄ in aqueous solution results from the combined effects of degradation by nanoscale zerovalent copper and sorption by the cation resin; thus the amount of CCl₄ both in aqueous solution and sorbed onto the resin were measured. The pseudo-first-order rate constant normalized by the surface-area and the mass concentration of nanoscale zerovalent copper (k SA) was 2.1 ± 0.1 × 10⁻² lh⁻¹ m⁻², approximately twenty times that of commercial powdered zerovalent copper (0.04 mm). Due to the exchange between Cu²⁺ and the strongly acidic ions (H⁺ or Na⁺), the pH was between 3 and 4 in unbuffered solution and Cu²⁺ at the concentration of less than 0.1 mg l⁻¹ was measured after the dechlorination reaction. In the above-ground application, resin as a support would facilitate the development of a process that could be designed for convenient emplacement and regeneration of porous reductive medium.

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Keywords: Nanoscale; Zerovalent metal; Copper; Dechlorination; Carbon tetrachloride

1. Introduction

Chlorinated aliphatic organic compounds, particularly containing one to three carbon atoms, such as carbon tetrachloride (CCl₄), trichloroethylene (TCE), and tetrachloroethylene (PCE), are widely used as industrial solvents in degreasing, washing, extraction, foaming, spraying, and manufacturing (Muftikian et al., 1995; Cheng and Wu, 2000). Improper use and disposal of these solvents has resulted in wide-spread occurrence in groundwater. In recent years, treatment of aqueous solution containing chlorinated solvents has attracted much attention. Conventional physicochemical methods accompanying the use of expensive chemicals or high energies largely restrict application at the field scale. Biological processes may be effective, but conditions must be well controlled to enable microorganisms to grow. Thus, it may not always be practical. Phytoremediation, using the ability of plants to remove and degrade chlorinated solvents, may offer a cost-effective, in situ, and safe alternative to conventional physicochemical methods (McCUTCHEON and SCHOOR, 2003).
The use of zerovalent metals as reductants to degrade chlorinated organic compounds is cost-effective and effectively reduces the concentration of target contaminants (Gillham and O'Hannesin, 1994; Matheson and Tratnyek, 1994; Agrawal and Tratnyek, 1996; Orth and Gillham, 1996; Gu et al., 1999; Phillips et al., 2000). Being inexpensive and benign in environment, zerovalent iron (Fe⁰) is the most applied reactive metal; the potential for reducing more complex anthropogenic chemicals such as pentachlorophenol (Kim and Carraway, 2000), pesticides (Sayles et al., 1997; Eykholt and Davenport, 1998) and azo dyes (Nam and Tratnyek, 2000) has been demonstrated in the past few years. Recently, however, several drawbacks associated with the reaction between Fe⁰ and chlorinated organics included (1) as the reaction proceeds, the pH in the reaction zone slightly rises (Matheson and Tratnyek, 1994; Phillips et al., 2000; Doong et al., 2003), caused by the net result of a number of chemical processes including iron corrosion and subsequent precipitation of ferrous iron (Su and Puls, 2004). At elevated pH, the precipitation of iron hydroxides and iron carbonates form and decrease reactivity by reducing the exposure of the iron surface to aqueous solution (Chen et al., 2001). The media can become plugged and cemented into pipes. (2) High concentration of iron ions, coming from several oxidation reactions, in the effluent of a above-ground reactor leads to the sludge disposal and treatment at additional cost and the potential blocking of pipes of the treatment system. (3) The difficulty and frequent replacement or the chemical reconditioning of the massive iron particles in the above-ground reactor results in higher costs.

The available surface area of iron is the most important factor that governs the reduction rate. Studies have demonstrated the reductive degradation rates for several target compounds are proportional to the total surface area of iron (Matheson and Tratnyek, 1994; Agrawal and Tratnyek, 1996; Siantar et al., 1996; Huang et al., 1998; Su and Puls, 1999). A nanoparticle is conventionally defined as the diameter of a particle in the 1–100 nm range (Klabunde, 2001). Reducing the particle size of an equivalent mass of Fe⁰ into the nanoscale range sharply increases reactivity (Boronina et al., 1995; Wang and Zhang, 1997; Choe et al., 2000). Zhang et al. (1998) reported that the surface-area-normalized rate constant of the reaction between nanoscale Fe⁰ and TCE or CCl₄ can be increased by a factor of 10–100 compared to commercial Fe⁰ powder (<10 μm). The dramatically increased reactivity results from a higher ratio of surface area to volume of nanoscale Fe⁰, higher levels of stepped surface (stepped surface is also known as high Miller index which usually has a step structure), and higher surface energies compared to powdered Fe⁰ (Zhang et al., 1998). Nanoscale Fe⁰ particle suspensions can be applied in an above-ground treatment reactor or directly injected into contaminated aquifers. However, the critical obstacles in the application of nanoscale Fe⁰ to reduce chlorinated solvents are (1) the immediate oxidation in air or water due to the active surface of nanoscale Fe⁰, (2) immediate agglomeration into micrometer particles due to the tendency to reduce the high surface energies, and (3) difficulty in separating such small particles from the effluent of the above-ground reactor when nonmagnetic iron oxides such as goethite and hematite form.

Use of a support medium to stabilize and isolate a metal particle avoids some problems with nanoscale particles (Ziolo et al., 1992). In this study, attachment to a commercial cation resin not only prevents nanoscale zerovalent metal agglomeration but also recycles metal ions (the product of the dechlorination reaction) by simultaneous ion exchange. Furthermore, attachment to a fixed medium prevents metal ions from being washed out of the treatment system. Moreover, acidic cation resins release H⁺ or Na⁺ to exchange equivalent metal ions and cause acidic conditions which can inhibit precipitation of metal salts. The polymer matrix is also light and easily deformable. The concept for the use of nanoscale zerovalent metal coated resin mesh in an above-ground reactor and the reactions are shown in Fig. 1.

In this work, zerovalent copper was chosen as an electron donor to degrade CCl₄. The use of copper as a reductant was preferred due to (1) the reliable in situ measurement of the surface area of resin-supported copper particles by temperature-programmed reduction (TPR) has been demonstrated (Grift et al., 1991), and (2) nanoscale zero valent copper exhibits relative stability in water, avoiding undesired competitive reactions. Based on these reasons, this study compared the dehalogenation kinetics of nanoscale and powdered copper particles. This study also evaluated feasibility of using reductive nanoscale zerovalent metal coated resin to degrade chlorinated organics in an above-ground reactor.

2. Experimental section

2.1. Chemicals

All aqueous solutions were made in water purified with a Milli-Q system (18.2 MΩ cm). High-pressure liquid chromatography grade carbon tetrachloride, chloroform, and dichloromethane were obtained from Aldrich (USA). Copper (II) nitrate trihydrate was from Alfa (USA). Copper powder was obtained from Riedel-de Haen (≈0.04 mm, >99.5%, GR grade, USA).

2.2. Preparation of nanoscale Cu⁰ coated resin

The polymer matrix used in this study is a commercial ion-exchange resin manufactured by Dow Chemical.
Company (USA) and marketed under the trade name Dowex™. The sulfonated polystyrene matrix is composed of spheres with diameters of 30–60 μm. The resin was first loaded with the desired concentration of Cu²⁺ from an aqueous solution of Cu(NO₃)₂·3H₂O, followed by thorough washing to remove excess physisorbed copper ions. After washing, the fresh samples were dried in air at 120 °C for 18 h. The dried samples were then reduced under a flow of H₂ (50 ml min⁻¹, Hoekloos (Netherlands)) from room temperature to 250 °C at 10 °C min⁻¹, then maintained at 250 °C for 30 min to remove the volatiles. The oven temperature was programmed to rise from ambient to 350 °C at 10 °C min⁻¹ and then staying at 350 °C for 1 h.

The oxidation states of copper on the resin were identified by electron spectroscopy for chemical analysis (ESCA). The ESCA measurements were performed by using a Vacuum Generators ECSALAB MKII photoelectron spectrometer (East Grinsted, UK) with an ALKα1,2 (1486.6 eV) X-ray source and a hemispherical 150 mm mean radius electron analyzer with a take-off angle of 90°. During the data acquisition, the pressure in the sample chamber did not exceed 6.7 × 10⁻¹⁸ Pa.

The morphology and size of the resulting nanoscale Cu⁰ coated resin was viewed with a transmission electron microscopy. The localized elemental information from the chosen region was determined with energy disperse X-ray spectroscopy (EDX) in conjunction with electron microscopy.

2.4. Surface area of attached copper particles

As described by Grift et al. (1991), the determination of the surface area of attached copper particles is based on the measurement of hydrogen consumption after surface oxidation of the copper by N₂O.

\[
2Cu + N₂O \rightarrow Cu₂O + N₂ \quad \text{(copper surface atoms only)} \tag{1}
\]

\[
Cu₂O + H₂ \rightarrow 2Cu + H₂O \tag{2}
\]

According to the surface oxidation measurements using N₂O at various temperatures (Evans et al., 1983), the
average site density is $1.4 \times 10^{19}$ Cu-atoms m$^{-2}$. Compared to the area of the thermal conductivity detector signals for 1 ml H$_2$ (40.9 nmol at 1 atm, 25 °C) undergoing temperature programmed reduction (A$_1$, ml H$_2$), the H$_2$ consumption of various copper ions on the resin undergoing temperature programmed reduction was obtained. The numbers of copper atoms at the surface ($N_{surf,Cu}$) were calculated from the stoichiometry of Eq. (2).

$$N_{surf,Cu} = \frac{A_{surf,Cu}}{A_1 \text{ml H}_2} \times 40.9 \times 10^{-6} \times N_v \text{ (mol)}$$

(3)

where $A_{surf,Cu}$ is the area of the thermal conductivity detector signal for the second TPR, and $N_v$ is 2 from the stoichiometry of Eq. (2). Copper surface area ($S_{Cu}$) on the resin is

$$S_{Cu} = \frac{N_{surf,Cu} \times N_{av} \times 1}{1.4 \times 10^{19}} \text{(m}^2 \text{ Cu g-resin}^{-1})$$

(4)

where $N_{av}$ is Avogadro constant ($6.023 \times 10^{23}$ mol$^{-1}$), and $W_{resin}$ is the mass (g) of the resin.

2.5. Reactor system

All dynamic experiments were performed for the degradation and sorption of CCl$_4$ by Cu$^0$ coated resin in a closed batch system with zero headspace (initial pH = 7.1–7.3). In these systems, the desired amount of Cu$^0$ coated resin was added into a 15 ml amber serum vial, sequentially filled up with Ar-purged unbuffered Milli-Q water. A 100 μl aliquot of CCl$_4$ (700 mg l$^{-1}$) was then added under the water surface. Immediately after CCl$_4$ addition, the vials were capped with Teflon silicone septa and aluminum seals and then mixed on a rotary shaker (50 rmp) at room temperature (24 ± 1 °C) in the dark.

2.6. Extraction and analysis

Aqueous phase and total system concentration of CCl$_4$ were determined by liquid–liquid and liquid–solid extraction using n-hexane as a solvent. The sampling method and extraction process was similar to the method reported by Burris et al. (1995). There are two stages to extract CCl$_4$ from residual aqueous phase and sorbed phase on the resin. Firstly, 5 ml of aqueous solution was collected from the amber serum vial by a gas-tight syringe through the septa, and simultaneously another disposable needle was used to inject 13 ml of helium to replace the liquid removed. Liquid–liquid extraction of the sample was performed with 5 ml n-hexane by axial rotation on a roller drum at 10 rpm, at room temperature, and in the dark for 30 min. The successive withdrawal of 8 ml of solution using the second gas-tight syringe was discarded. Secondly, another syringe of 5 ml n-hexane was spiked to the same vial to extract CCl$_4$ from residual aqueous solution and the resin by axial rotation on a roller drum under the conditions described above. Two separate 0.5 ml samples of the liquid–liquid and the liquid–solid extractions were measured using a HP5890 GC equipped with a DB-624 capillary column and an electron capture detector operated in the splitless mode. Temperature conditions were programmed as follows: oven temperature at 40 °C; injection port temperature at 180 °C; detector temperature at 300 °C. Ultrapure nitrogen was the GC carrier gas at a flow rate of 4.16 ml min$^{-1}$. Peaks were quantified by comparing retention time and peak areas with standards. The total CCl$_4$ mass (mg vial$^{-1}$) come from the sum of both the measured masses in the liquid–liquid and the liquid–solid extractions. The sorbed CCl$_4$ concentration on resin ($C_s$, μg∙CCl$_4$ g∙resin$^{-1}$) was determined by the difference of total and aqueous CCl$_4$ mass (Burris et al., 1995) as follows:

$$C_s = \frac{C_T - (C_w \times V_w)}{m_w}$$

(5)

where $C_T$ denotes the total mass, $C_w$ is the aqueous phase concentration, $V_w$ is the volume of aqueous solution, and $m_w$ is the mass of the added resin. All experiments were duplicated or triplicated.

The pH was measured with a Beckman Model 71 pH meter. The concentration of copper ions in aqueous solution was determined by an atomic absorption spectrophotometry (PerkinElmer AAnalyst 800™). Chloride was analyzed using an ion chromatograph (Dionex DX-100™).

3. Results and discussion

3.1. Reduction temperature

The temperature programmed reduction of Cu$^{2+}$ on the resin in a flow of H$_2$ and Ar (20 vol%, 60 ml min$^{-1}$) indicated two peaks of hydrogen consumption between 270 and 280 °C, and between 300 and 320 °C (Fig. 2). These peaks correspond to the reduction of Cu$^{2+}$ to Cu$^+$ and the reduction of Cu$^+$ to zerovalent copper. After a dried sample of Cu$^{2+}$ on the resin was reduced in a flow of H$_2$ and N$_2$ gas (20 vol%, 50 ml min$^{-1}$) at 300 °C for 3 h, all copper on the resin was reduced to zerovalence. Fig. 3 shows that only zerovalent copper remained. Thus, this ESCA established that the temperature was high enough to ensure complete reduction. Compared to the common aqueous-phase reduction with NaBH$_4$ or N$_2$H$_4$ as reduction agents, the use of H$_2$ and N$_2$ gas to reduce copper ions to zerovalent copper decreases the manufacturing expense because the more expensive chemicals are not required.
3.2. Characterization of nanoscale zerovalent copper coatings on resin

Based on transmission electron microscopy, Fig. 4 shows the distribution of 10 mg of zerovalent copper per gram of resin has a size in the range of 5–25 nm. The ion-exchange resin surface as analyzed by EDX was dominant by thionyl, sodium, and carbon. Thus, the resin easily held zerovalent copper in nanoscale patches or particles and did not destroy the ion-exchange groups during the process.

The effect of heat pretreatment (under a flow of 20 vol% H₂ and N₂ gas at 300 °C for 3 h) on the sorption of Cu²⁺ onto the resin was evaluated using the Langmuir isotherm. Another sample of resin was dried by a vacuum freeze-drying technique (26.8 Pa and −55 °C for 24 h). As shown in Fig. 5(a) and Table 1, the estimated
sorption capacities of Langmuir isotherm for both of the resin with the different pretreatments were 67.6 ± 10.9 nmol g⁻¹/C₀ for heat pretreatment and 79.5 ± 8.9 nmol g⁻¹/C₀ for vacuum freeze-drying. The results indicated the ion-exchange capability of the resin after heat pretreatment (a complete reduction procedure) nearly remained intact (the difference of two sorption capacities was not statistically significant with 95% confidence and 2 degrees of freedom using the independent t-test). Elemental analysis with EDX for the resin surface (magnification by 5000 times) revealed typical total copper contents of 1.5–2.0% (atomic percentage of total elements including carbon, oxygen, sulfur, sodium, and copper) before and after the dechlorination reaction, indicating little dislodging and few copper ions in solution. Therefore, nanoscale zerovalent copper coated resin possessed high mechanical stability in water. After reaction, the copper on the resin was dominantly oxidized into CuO as identified by ESCA (Fig. 3).

3.3. Degradation and sorption of carbon tetrachloride using resin coated with nanoscale zerovalent copper

The disappearance of CCl₄ from aqueous solutions may be due to degradation reactions by zerovalent copper or sorption onto the resin. Sorption of CCl₄ from solution onto the resin can be described by the Langmuir isotherm (Fig. 5(b)). Table 1 provides that the observed maxima as 11.5 ± 6.2 and 770.1 ± 41.5 nmol g⁻¹/C₀ for CCl₄ on the powdered copper particles and the resin, respectively. Thus, the sorption of aqueous CCl₄ onto the resin dominates sorption onto the zerovalent copper.

A conceptual model of the nanoscale zerovalent copper–resin–CCl₄–water system incorporating the degradation reaction by zerovalent copper and sorption and desorption to the resin is similar to that proposed by Burris et al. (1998). The loss of total mass of CCl₄ in a closed reactor was fitted with a first-order rate equation of the form

\[ -\frac{dC_T}{dt} = k_a \times C_w = k_{SA} \times a_s \times \rho_m \times C_w \]  

(6)

where \( C_T, C_w \) and \( C_s \) are the total, aqueous, and sorbed-phase CCl₄ concentrations μg/vial, respectively; \( t \) is the reaction time (h); \( k_a \) is the degradation rate constant (h⁻¹); \( k_{SA} \) is the surface-area-normalized rate coefficient (l h⁻¹ m⁻²); \( a_s \) is the specific surface area of metal (m² g⁻¹); and \( \rho_m \) is the mass concentration of the metal (g l⁻¹). The disappearance rate of aqueous mass with respect to time was due sorption, desorption and degradation reaction.

\[ -\frac{dC_w}{dt} = \chi_s C_w - \chi_d C_s \]  

(7)

where \( \chi_s \) and \( \chi_d \) are the sorption and desorption rate constants, respectively. Despite the sorption onto the zerovalent copper surface, the CCl₄ concentrations were measured as aqueous phase in solution and sorbed phase on the resin. Each vial without headspace contained 0.2 or 0.5 g resin coated with nanoscale zerovalent copper (25 mg-Cu/g-resin), or 0.3 g commercial powdered copper (0.04 mm). In separate controls, total concentrations (mass/vial) were stable during the same period. The extraction recoveries for CCl₄ from aqueous and sorbed phases in the blank resin vials (0.2 g-resin/vial) ranged from 91% to 98%.

Initially, the specific surface area of nanoscale zerovalent copper supported on the resin and for the powdered copper were measured by hydrogen consumption

![Fig. 5. Sorption isotherms: (a) Cu²⁺ on the resin pretreated by vacuum freeze-drying and heat pretreatment. (b) CCl₄ on the resin and the powdered Cu particles. Fitted lines are based on the Langmuir equation using the parameters in Table 1.](image-url)
during temperature programmed reduction. The values are shown in Table 2. The surface area of nanoscale zerovalent copper is approximately 22 times that of powdered copper.

As shown in Fig. 6(a) and (b), complete degradation of CCl₄ in 0.2 and 0.5 g nanoscale zerovalent copper coated resin per vial took about 16–17 h and 5–6 h, respectively. The observed degradation rates ($k_{\text{obs}}$) were 0.24 ± 0.02 h⁻¹ for 0.2 g nanoscale zerovalent copper coated resin per vial and 0.80 ± 0.03 h⁻¹ for 0.5 g nanoscale zerovalent copper coated resin per vial and then normalized with the specific surface area (1.12 ± 0.02 m² Cu/g-resin) and the mass concentration of nanoscale zerovalent copper coated resin (13.3 g l⁻¹) to $k_{\text{SA}}$, 0.016 ± 0.002 and 0.021 ± 0.001 h⁻¹ m⁻², respectively. The $k_{\text{obs}}$ and $k_{\text{SA}}$ for powdered copper were 0.028 ± 0.004 h⁻¹ and 0.0010 ± 0.00011 h⁻¹ m⁻², respectively. Reducing the size of copper particles to a nanoscale would sharply increase $k_{\text{SA}}$ by a factor of about 24. Other experiments (0.5 g zerovalent copper coated resin per vial) revealed that the $k_{\text{obs}}$ for nanoscale zerovalent copper coated resin submerged continuously in Ar-purged Milli-Q water for 7 d was 0.73 ± 0.004 h⁻¹. Then, the same nanoscale zerovalent copper coated resin was regenerated by H₂ at 300 °C for 3 h, increasing the $k_{\text{obs}}$ to 0.85 ± 0.003 h⁻¹. Thus the reactivity of nanoscale zerovalent copper coated resin was decreased in the long-term reaction, but was restored by H₂ treatment (95% confidence and 4 degrees of freedom using the independent t-test).

The sorption and desorption rate constants $k_s$ and $k_d$ were estimated by fitting the observed aqueous CCl₄ concentration $C_w$ with the exact solution of Eq. (7) derived by Burris et al. (1998). The sorption and desorption rate constants $k_s$ and $k_d$ were respectively 0.21 ± 0.002 and 0.28 ± 0.002 h⁻¹ for 0.2 g nanoscale zerovalent copper coated resin per vial; these were 0.41 ± 0.03 and 0.30 ± 0.03 h⁻¹ for 0.5 g nanoscale zerovalent copper coated resin per vial. Increasing nanoscale zerovalent copper coated resin loading per vial increased the sorption rate constant but not the desorption rate constant. As shown in Fig. 6, the initial $C_w$ data were matched by the estimated values of the exact solution with values of constant $k_s$ and $k_d$ (within 7 and 2 h, respectively). The apparent differences between the observed and estimated data in the final period of reaction implies the desorption rate may be not first-order (the estimated deposition rate is slower than the actual rate).

### 3.4. Residual copper ions concentration and pH

The residual copper ions in the effluent are the product of the reaction between CCl₄ and Cu⁰. These are considered to be hazardous species and the concentrations must be reduced below those required by effluent standards. Fig. 7 shows the residual copper ions concentration and the pH of both commercial powdered copper and nanoscale zerovalent copper coated resin. For a powdered Cu–CCl₄–H₂O system, the residual copper ions exceeded 1.0 mg l⁻¹, falling to 0.6 mg l⁻¹ for a long

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**Table 2** Specific surface areas of resin coated with nanoscale zerovalent copper and powdered copper

<table>
<thead>
<tr>
<th>Sample</th>
<th>Mass of sample (g)</th>
<th>H₂ consumption (nmol/g-sample)</th>
<th>Copper surface area, $S_{Cu}$ (m²-Cu/g-resin)</th>
<th>Copper surface area, $S_{Cu}$ (m²-Cu/g-Cu)</th>
</tr>
</thead>
<tbody>
<tr>
<td>25 mg-Cu⁰/g-resin</td>
<td>0.20</td>
<td>13.0 ± 0.1</td>
<td>1.12 ± 0.02</td>
<td>44.8 ± 0.08</td>
</tr>
<tr>
<td>Powdered Cu⁰</td>
<td>0.30</td>
<td>23.9 ± 0.3</td>
<td>–</td>
<td>2.05 ± 0.04</td>
</tr>
</tbody>
</table>

**Table 1** Fitted Langmuir parameters for sorption of Cu²⁺ by the resin with different pretreatments (Experiment 1) and for sorption of CCl₄ by the resin and the powdered copper particles (Experiment 2)

<table>
<thead>
<tr>
<th>Experiment 1: Cu²⁺ sorption</th>
<th>Experiment 2: CCl₄ sorption</th>
</tr>
</thead>
<tbody>
<tr>
<td>Heat pretreatment</td>
<td>Vacuum freeze-drying</td>
</tr>
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<td>(I)</td>
<td>(I)</td>
</tr>
<tr>
<td>$S_m$ (nmol g⁻¹)</td>
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</tr>
<tr>
<td>(79.5)</td>
<td></td>
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<tr>
<td>$K_L$ (mM⁻¹)</td>
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<tr>
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<td>(0.060)</td>
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<tr>
<td>(0.048)</td>
<td>(0.047)</td>
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<tr>
<td>$r^2$</td>
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</tr>
<tr>
<td>(0.989)</td>
<td>(0.999)</td>
</tr>
</tbody>
</table>

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</tr>
</tbody>
</table>

$^a$ Averaged results from replicate tests were reported.
period, due to the precipitation of metal carbonate or oxide (Fig. 3 shows the build up of CuO). However, these concentrations are typically under 0.1 mg l$^{-1}$ and the pH dropped to 3–4 in nanoscale zerovalent copper coated resin system. The difference in copper ion concentration in aqueous solution between copper powder and nanoscale zerovalent copper coated resin results from the ion exchange of the resin as a support. On the nanoscale zerovalent copper coated resin, when zerovalent copper is oxidized into copper ion, H$^+$ or Na$^+$ are released from the resin to exchange copper ion. Thus, the use of the resin as a support not only removes copper ions from the solution but also drops pH to acidic conditions.

The possible copper contamination resulting from the displacement by other multivalent cations present in groundwater limits the potential in situ application of nanoscale zerovalent copper coated resin. This competition depends on the composition of groundwater is inevitable and mainly causes the decrease in copper recovery over time. Considering metal toxicity and the required reduction temperature of metal ions, alternative metals like tin may to be more applicable in situ.

4. Conclusions

Nanoscale zerovalent copper coated resin, synthesized in a flow of H$ _2$ and N$ _2$ gas (20 vol%, 50 ml min$ ^{-1}$) at 300 °C for 3 h, is an efficient and mechanically stable reductant for the degradation of CCl$_4$ in water. Reducing the size of the copper particles to a nanoscale increases the reactivity by a factor of about 24. The use of the cation-resin as a support decreases the copper ions in the effluent at a concentration of less 0.1 mg/l and simultaneously maintains the solution pH at 3–4. Over the long term, this reductant can be restored to reactivity by H$ _2$. Thus, advantages of the application of nanoscale zerovalent copper coated resin as reductive material to degrade chlorinated solvents can be attributed to (1) the increase in the rate constant due to the nanosize of metal particles; (2) the combined effect of degradation and sorption; (3) the acid pH range during the dechlorination process; (4) the recycling of metal ions in the solution. In the above-ground application, this reduc-
tant would facilitate the development of a process that could be designed for convenient emplacement and regeneration of porous reductive medium. In situ, metal coated resin may not be as useful until the effects of competitive ions in local groundwater can be related to the release of toxic metals.

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